

Maximum ratings, at  $T_j=25\text{ °C}$ , unless otherwise specified

| Parameter                           | Symbol        | Conditions         | Value | Unit |
|-------------------------------------|---------------|--------------------|-------|------|
| Continuous diode forward current    | $I_S$         | $T_C=25\text{ °C}$ | 6     | A    |
| Diode pulse current <sup>2)</sup>   | $I_{S,pulse}$ |                    | 18    |      |
| Reverse diode $dv/dt$ <sup>4)</sup> | $dv/dt$       |                    | 4     | V/ns |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Thermal characteristics

|                                                             |            |                                      |   |   |     |     |
|-------------------------------------------------------------|------------|--------------------------------------|---|---|-----|-----|
| Thermal resistance, junction - case                         | $R_{thJC}$ |                                      | - | - | 1.5 | K/W |
| Thermal resistance, junction - ambient                      | $R_{thJA}$ | leaded                               | - | - | 62  |     |
| Soldering temperature, wave soldering only allowed at leads | $T_{sold}$ | 1.6 mm (0.063 in.) from case for 10s | - | - | 260 | °C  |

Electrical characteristics, at  $T_j=25\text{ °C}$ , unless otherwise specified

### Static characteristics

|                                  |               |                                                                   |     |      |     |               |
|----------------------------------|---------------|-------------------------------------------------------------------|-----|------|-----|---------------|
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | $V_{GS}=0\text{ V}$ , $I_D=250\text{ }\mu\text{A}$                | 800 | -    | -   | V             |
| Avalanche breakdown voltage      | $V_{(BR)DS}$  | $V_{GS}=0\text{ V}$ , $I_D=6\text{ A}$                            | -   | 870  | -   |               |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS}=V_{GS}$ , $I_D=0.25\text{ mA}$                            | 2.1 | 3    | 3.9 |               |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS}=800\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=25\text{ °C}$  | -   | -    | 10  | $\mu\text{A}$ |
|                                  |               | $V_{DS}=800\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=150\text{ °C}$ | -   | 50   | -   |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                        | -   | -    | 100 | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS}=10\text{ V}$ , $I_D=3.8\text{ A}$ , $T_j=25\text{ °C}$    | -   | 0.78 | 0.9 | $\Omega$      |
|                                  |               | $V_{GS}=10\text{ V}$ , $I_D=3.8\text{ A}$ , $T_j=150\text{ °C}$   | -   | 2.1  | -   |               |
| Gate resistance                  | $R_G$         | $f=1\text{ MHz}$ , open drain                                     | -   | 1.2  | -   | $\Omega$      |

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics**

|                                                            |              |                                                                                                                           |   |     |   |    |
|------------------------------------------------------------|--------------|---------------------------------------------------------------------------------------------------------------------------|---|-----|---|----|
| Input capacitance                                          | $C_{iss}$    | $V_{GS}=0\text{ V}, V_{DS}=100\text{ V},$<br>$f=1\text{ MHz}$                                                             | - | 785 | - | pF |
| Output capacitance                                         | $C_{oss}$    |                                                                                                                           | - | 33  | - |    |
| Effective output capacitance, energy related <sup>5)</sup> | $C_{o(er)}$  | $V_{GS}=0\text{ V}, V_{DS}=0\text{ V}$<br>to 480 V                                                                        | - | 26  | - |    |
| Effective output capacitance, time related <sup>6)</sup>   | $C_{o(tr)}$  |                                                                                                                           | - | 69  | - |    |
| Turn-on delay time                                         | $t_{d(on)}$  | $V_{DD}=400\text{ V},$<br>$V_{GS}=0/10\text{ V}, I_D=6\text{ A},$<br>$R_G=15\text{ }\Omega, T_j=25\text{ }^\circ\text{C}$ | - | 25  | - | ns |
| Rise time                                                  | $t_r$        |                                                                                                                           | - | 15  | - |    |
| Turn-off delay time                                        | $t_{d(off)}$ |                                                                                                                           | - | 72  | - |    |
| Fall time                                                  | $t_f$        |                                                                                                                           | - | 8   | - |    |

**Gate Charge Characteristics**

|                       |               |                                                                            |   |     |    |    |
|-----------------------|---------------|----------------------------------------------------------------------------|---|-----|----|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD}=640\text{ V}, I_D=6\text{ A},$<br>$V_{GS}=0\text{ to }10\text{ V}$ | - | 4   | -  | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                                            | - | 15  | -  |    |
| Gate charge total     | $Q_g$         |                                                                            | - | 31  | 41 |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                                            | - | 5.5 | -  | V  |

**Reverse Diode**

|                               |           |                                                                               |   |     |     |               |
|-------------------------------|-----------|-------------------------------------------------------------------------------|---|-----|-----|---------------|
| Diode forward voltage         | $V_{SD}$  | $V_{GS}=0\text{ V}, I_F=I_S=6\text{ A},$<br>$T_j=25\text{ }^\circ\text{C}$    | - | 1   | 1.2 | V             |
| Reverse recovery time         | $t_{rr}$  | $V_R=400\text{ V}, I_F=I_S=6\text{ A},$<br>$di_F/dt=100\text{ A}/\mu\text{s}$ | - | 520 | -   | ns            |
| Reverse recovery charge       | $Q_{rr}$  |                                                                               | - | 5   | -   | $\mu\text{C}$ |
| Peak reverse recovery current | $I_{rrm}$ |                                                                               | - | 18  | -   | A             |

<sup>1)</sup> J-STD20 and JESD22

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$

<sup>3)</sup> Repetitive avalanche causes additional power losses that can be calculated as  $P_{AV}=E_{AR}*f$ .

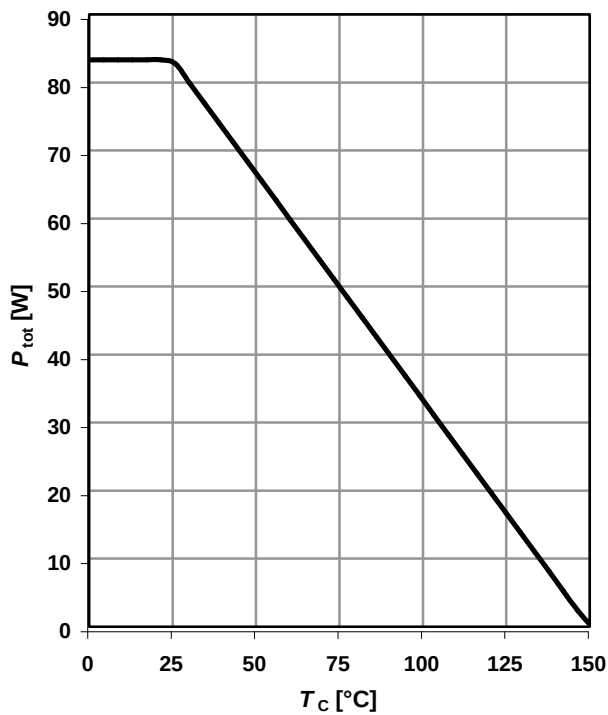
<sup>4)</sup>  $I_{SD}=I_D, di/dt=400\text{ A}/\mu\text{s}, V_{DClk}=400\text{ V}, V_{peak}<V_{(BR)DSS}, T_j<T_{j,max}$ , identical low side and high side switch

<sup>5)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

<sup>6)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .

## 1 Power dissipation

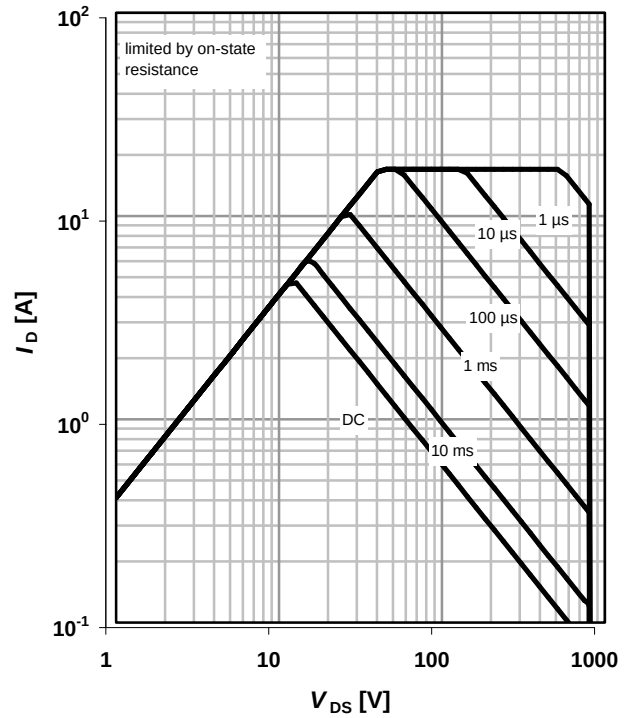
$$P_{\text{tot}} = f(T_C)$$



## 2 Safe operating area

$$I_D = f(V_{DS}); T_C = 25^\circ\text{C}; D = 0$$

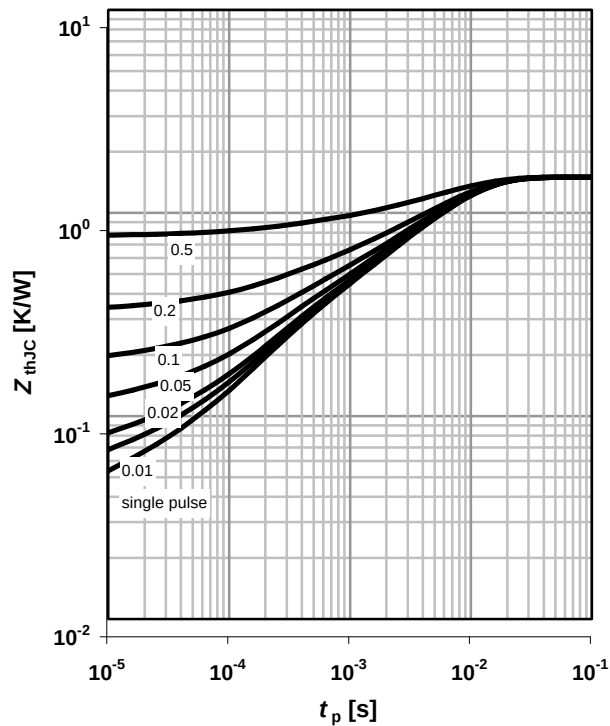
parameter:  $t_p$



## 3 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p)$$

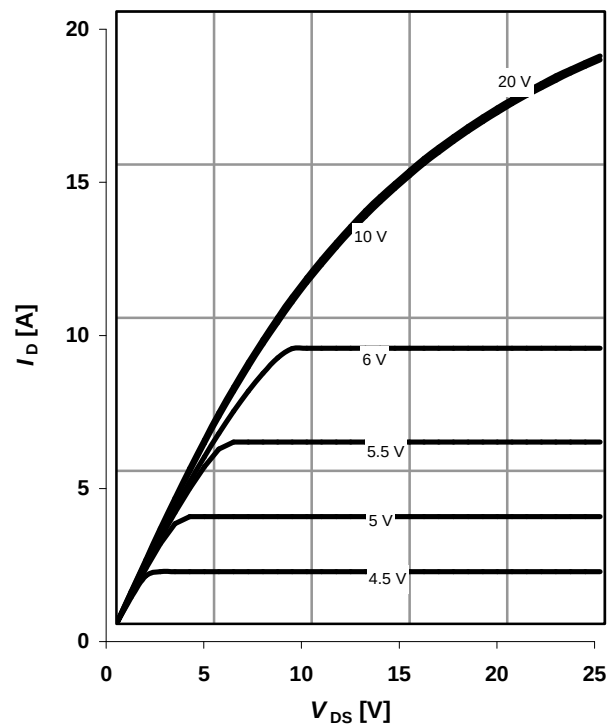
parameter:  $D = t_p / T$



## 4 Typ. output characteristics

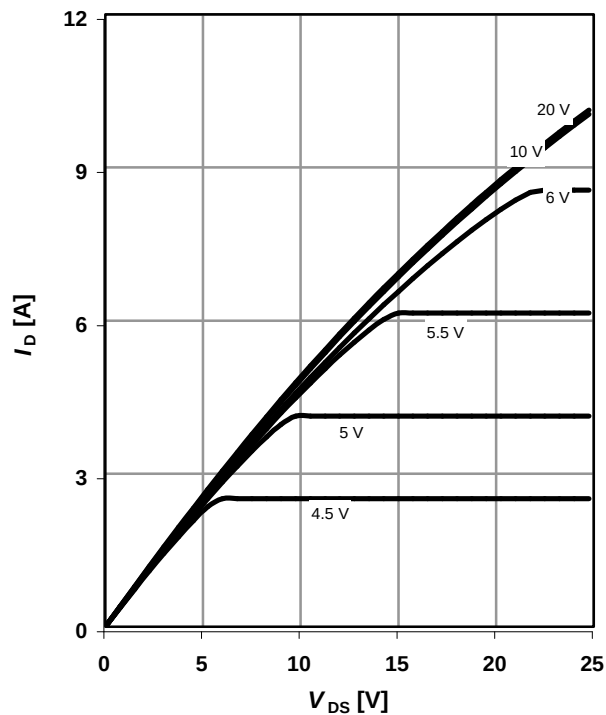
$$I_D = f(V_{DS}); T_J = 25^\circ\text{C}; t_p = 10 \mu\text{s}$$

parameter:  $V_{GS}$



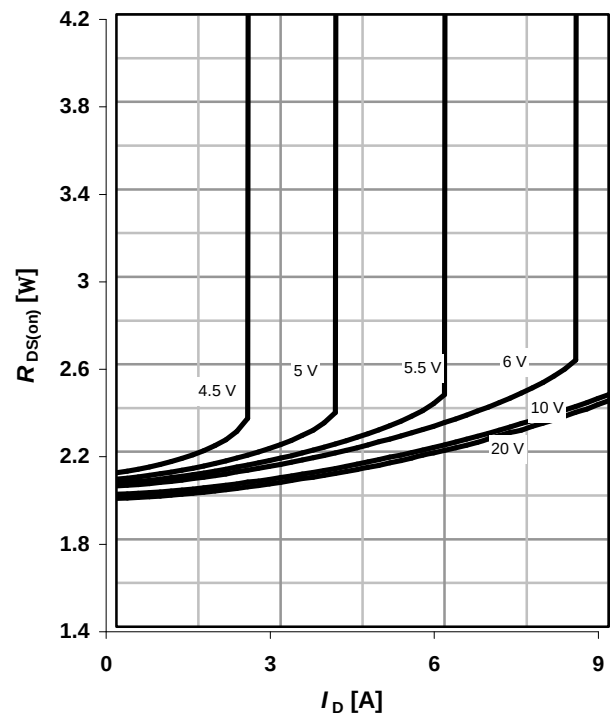
### 5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 150^\circ\text{C}; t_p = 10\ \mu\text{s}$ 

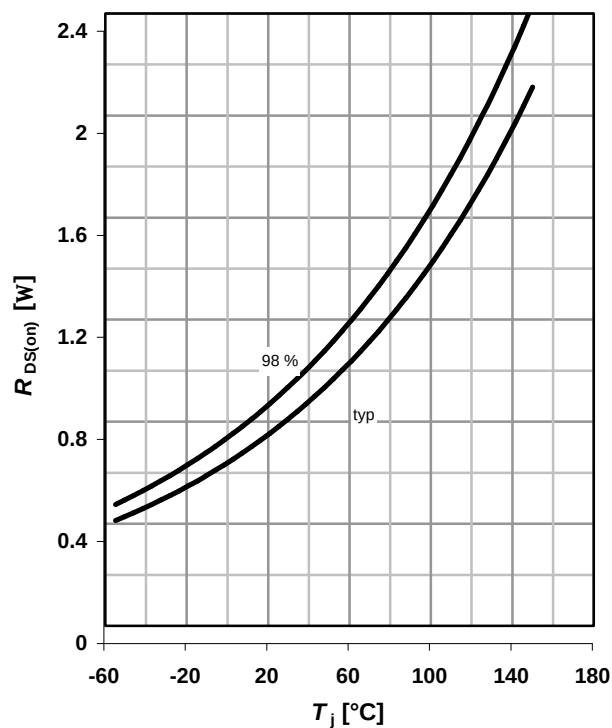
parameter:  $V_{GS}$ 


### 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 150^\circ\text{C}$ 

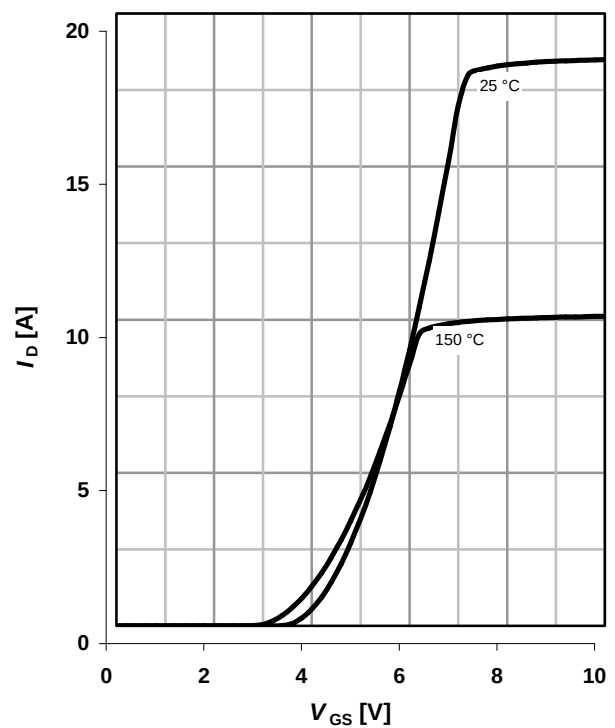
parameter:  $V_{GS}$ 


### 7 Drain-source on-state resistance

 $R_{DS(on)} = f(T_j); I_D = 3.8\ \text{A}; V_{GS} = 10\ \text{V}$ 


### 8 Typ. transfer characteristics

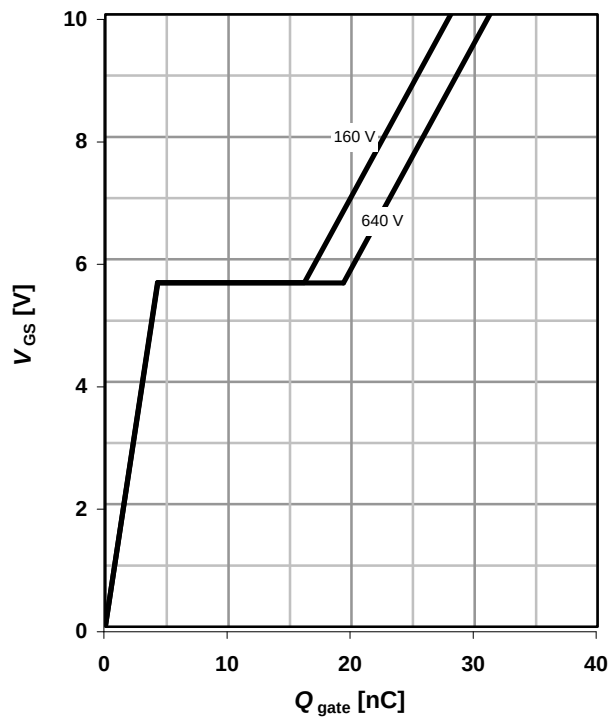
 $I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)\text{max}}; t_p = 10\ \mu\text{s}$ 

parameter:  $T_j$ 


### 9 Typ. gate charge

$V_{GS}=f(Q_{gate}); I_D=6\text{ A}$  pulsed

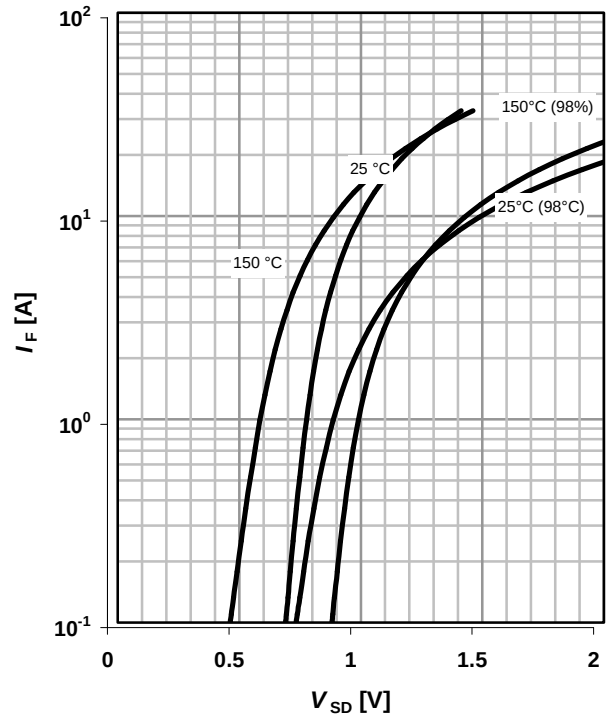
parameter:  $V_{DD}$



### 10 Forward characteristics of reverse diode

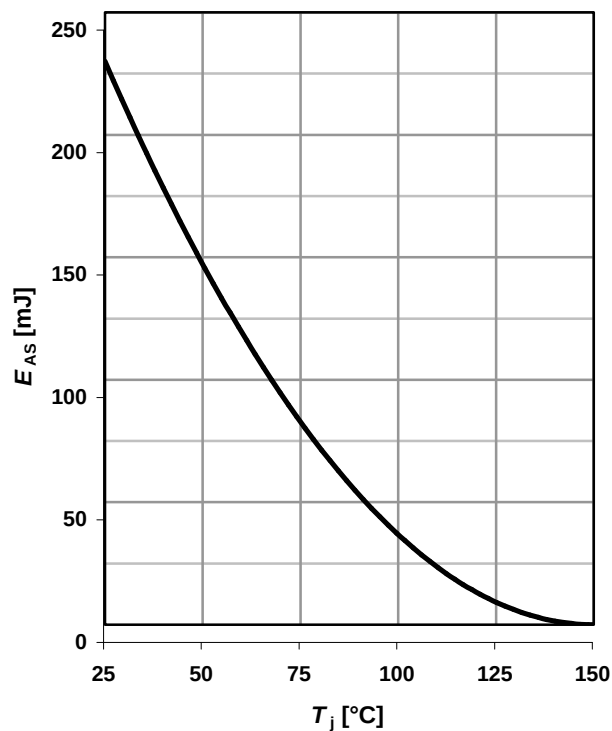
$I_F=f(V_{SD}); t_p=10\text{ }\mu\text{s}$

parameter:  $T_j$



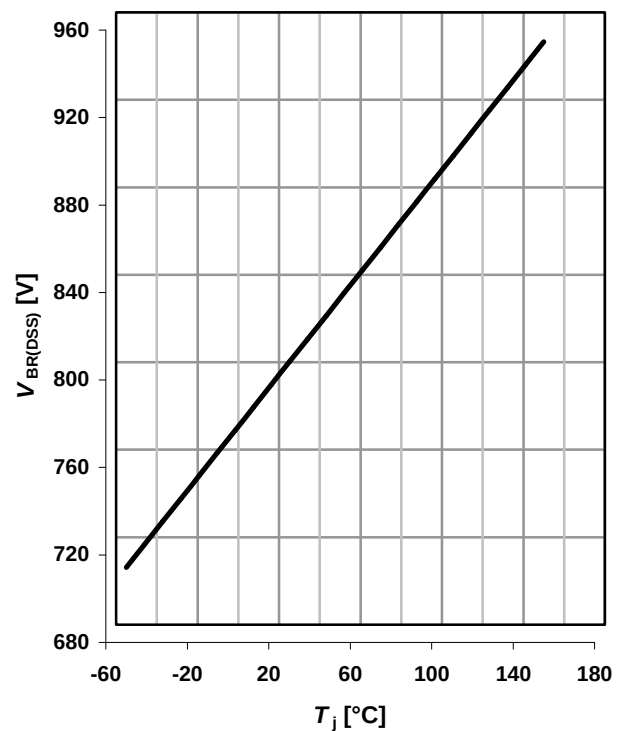
### 11 Avalanche energy

$E_{AS}=f(T_j); I_D=1.2\text{ A}; V_{DD}=50\text{ V}$



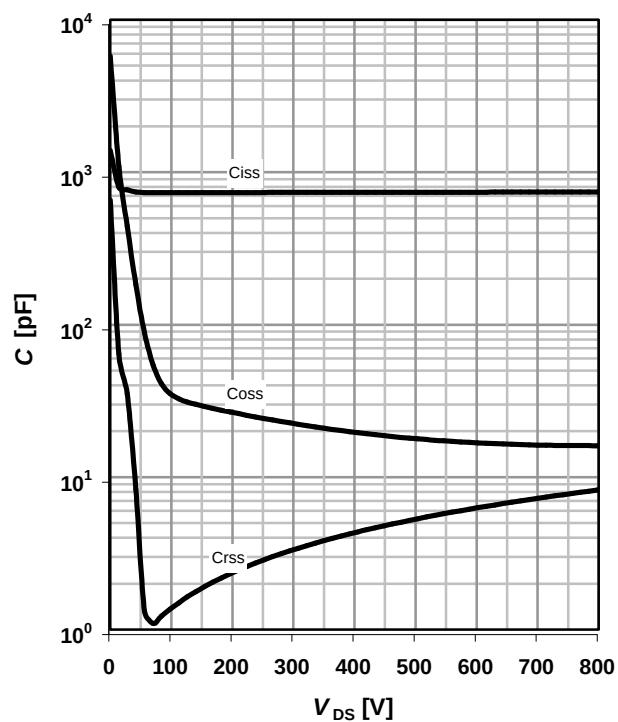
### 12 Drain-source breakdown voltage

$V_{BR(DSS)}=f(T_j); I_D=0.25\text{ mA}$



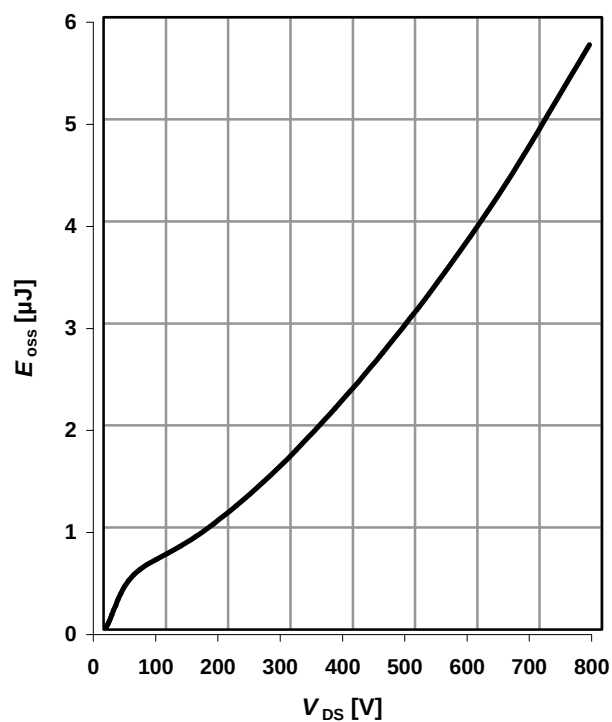
### 13 Typ. capacitances

$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

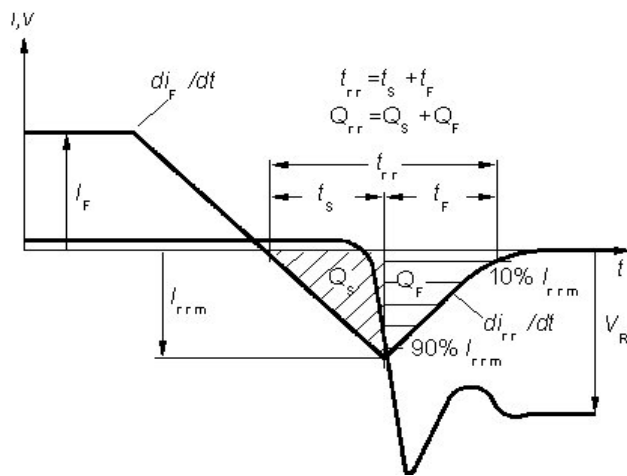


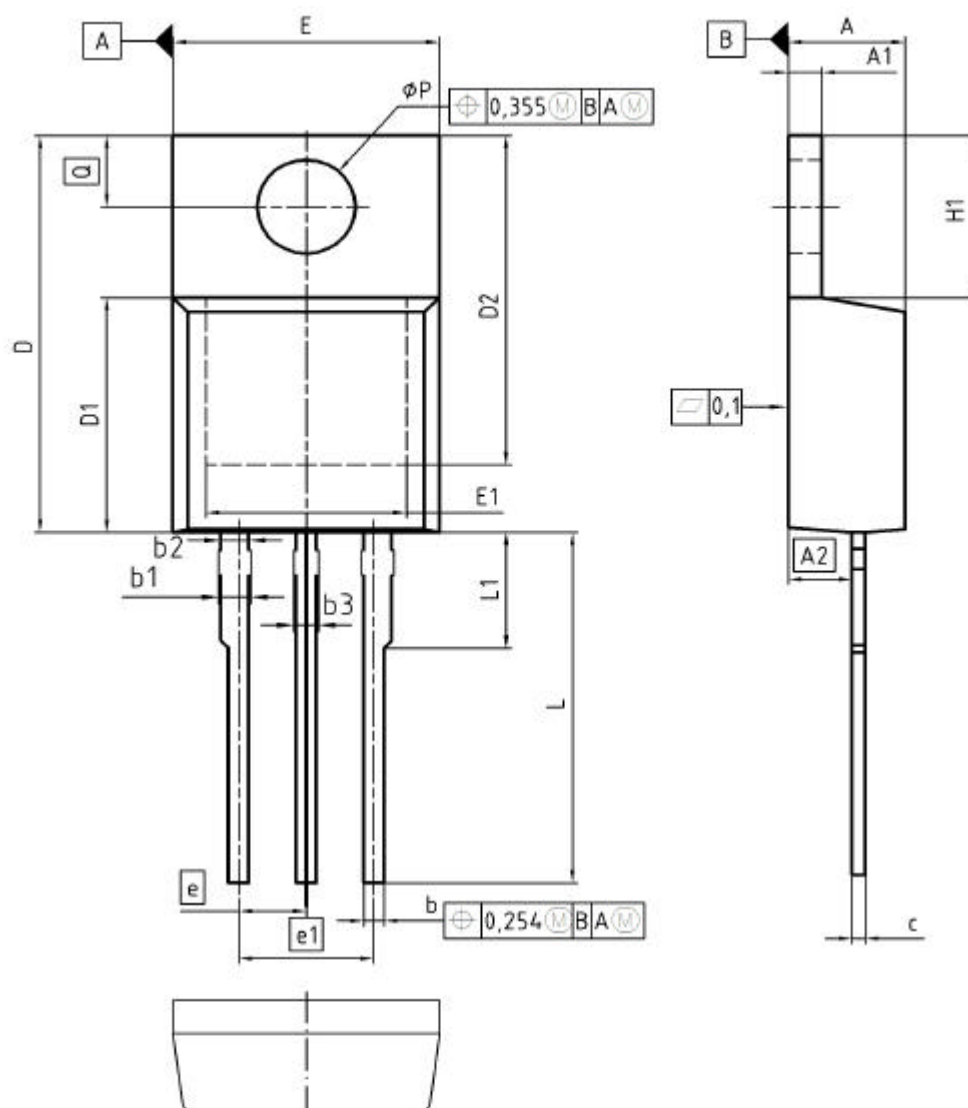
### 14 Typ. Coss stored energy

$E_{oss} = f(V_{DS})$

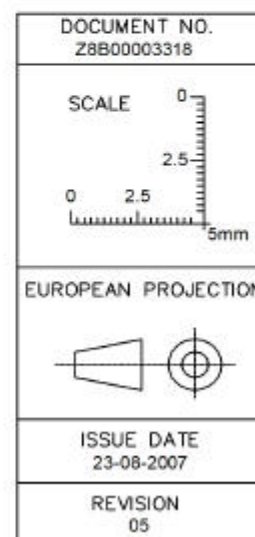


## Definition of diode switching characteristics



**PG-TO220-3: Outline**


| DIM      | MILLIMETERS |       | INCHES |       |
|----------|-------------|-------|--------|-------|
|          | MIN         | MAX   | MIN    | MAX   |
| A        | 4.30        | 4.57  | 0.169  | 0.180 |
| A1       | 1.17        | 1.40  | 0.046  | 0.055 |
| A2       | 2.15        | 2.72  | 0.085  | 0.107 |
| b        | 0.65        | 0.86  | 0.026  | 0.034 |
| b1       | 0.95        | 1.40  | 0.037  | 0.055 |
| b2       | 0.95        | 1.15  | 0.037  | 0.045 |
| b3       | 0.65        | 1.15  | 0.026  | 0.045 |
| c        | 0.33        | 0.60  | 0.013  | 0.024 |
| D        | 14.81       | 15.95 | 0.583  | 0.628 |
| D1       | 8.51        | 9.45  | 0.335  | 0.372 |
| D2       | 12.19       | 13.10 | 0.480  | 0.516 |
| E        | 9.70        | 10.36 | 0.382  | 0.408 |
| E1       | 6.50        | 8.60  | 0.256  | 0.339 |
| e        | 2.54        |       | 0.100  |       |
| e1       | 5.08        |       | 0.200  |       |
| N        | 3           |       | 3      |       |
| H1       | 5.90        | 6.90  | 0.232  | 0.272 |
| L        | 13.00       | 14.00 | 0.512  | 0.551 |
| L1       | -           | 4.80  | -      | 0.189 |
| $\phi P$ | 3.60        | 3.89  | 0.142  | 0.153 |
| Q        | 2.60        | 3.00  | 0.102  | 0.118 |





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